

Preface

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Clitic Phenomena in European Languages

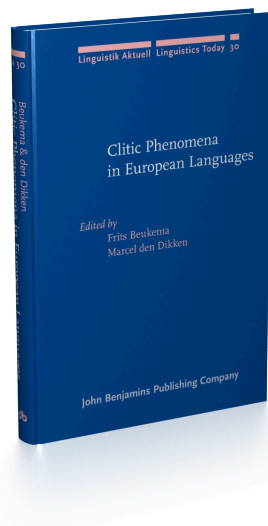
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Preface

The papers included in this volume were first presented at the workshop on “Clitic Phenomena in English and Other European Languages”, which was held during the fourth conference of the European Society for the Study of English at Lajos Kossuth University in Debrecen (Hungary), 5–9 September 1997. The authors who responded to our call for papers and to our various deadlines for handing in versions of their papers deserve our warmest thanks. The contributions were subsequently refereed and revised in the light of reviewers’ comments. One contribution, by Ljiljana Progovac, was invited by the editors.

We are especially grateful to Steven Franks for writing the overview paper *Clitics at the Interface*, which opens the volume.

Our debt to the linguists who assisted us in the reviewing is enormous. Their help was freely and generously given; without it the volume could not have come about.

A final word of thanks must go to Klaske van Leyden, who helped us in the final stages of preparing the manuscript for the press. Without her wizardry on the computer and her phenomenal accuracy, the book would have been far longer in the making.

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